

Notice of References Cited	Application/Control No. 10/717,476		Applicant(s)/Patent Under Reexamination SAITOH ET AL.	
	Examiner Helen C. Kwok		Art Unit 2856	Page 1 of 1

U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
	A	US-6,740,982	05-2004	Sauter et al.	257/780
	B	US-6,263,735	07-2001	Nakatani et al.	73/514.36
	C	US-5,057,906	10-1991	Ishigami, Toshio	257/706
	D	US-			
	E	US-			
	F	US-			
	G	US-			
	H	US-			
	I	US-			
	J	US-			
	K	US-			
	L	US-			
	M	US-			

FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N	JP 10-123166	05-1998	Japan	Ao et al.	---
	O	JP 6-331652	12-1994	Japan	Takami et al.	---
	P					
	Q					
	R					
	S					
	T					

NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	
	V	
	W	
	X	

*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)
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